

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of:

Xin Zhang

Application No.:

Group Art Unit:

Filed: January 2, 2004

Examiner:

For: YIELD PERCENTAGE MANAGING METHOD AND APPARATUS, AND COMPUTER-READABLE STORAGE MEDIUM

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
PO Box 1450
Alexandria, VA 22313-1450

Sir:

In accordance with the duty of disclosure provisions of 37 CFR § 1.56, there is hereby provided certain information which the Examiner may consider material to the examination of the subject U.S. patent application. It is requested that the Examiner make this information of record if it is deemed material to the examination of the subject application.

1. Enclosures accompanying this Information Disclosure Statement are:
 - 1a. Form PTO-1449.
 - 1b. Copies of IDS citations.
 - 1c. An English language copy of search report(s) from a counterpart foreign application or a PCT International Search Report.
 - 1d. English language translation (complete or relevant portion(s)) attached to each non-English language publication.
 - 1e. Explanations of Relevancy of References (ATTACHMENT 1(e), hereto) for providing a concise explanation of each non-English publication.
2. In accordance with 37 CFR § 1.98, a concise explanation of what is presently understood to be the relevance of each non-English language publication is
(Check appropriate Items 2a, 2b, 2c and/or 2d)
 - 2a. satisfied because all non-English language publications were cited on the enclosed "English-language version of the search report or action which indicates the degree of relevance found by the foreign office". (See MPEP 609, Minimum Requirements for an Information Disclosure Statement, Part A(3): Concise Explanation of Relevance, pp. 600-100 to 600-101, Rev. 1, Feb. 2000.)
 - 2b. set forth in the application.

2c. satisfied because an English language translation (complete or relevant portion(s)) is attached to each non-English language publication.

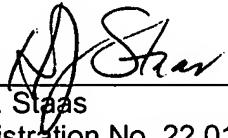
2d. enclosed as Attachment 1(e), hereto.

3. No admission is made that the information cited in this Statement is, or is considered to be, material to patentability nor a representation that a search has been made (other than search report(s) from a counterpart foreign application or a PCT International Search Report, if submitted herewith). 37 CFR §§ 1.97(g) and (h).

Respectfully submitted,

STAAS & HALSEY LLP

Dated: January 2, 2004
1201 New York Ave., N.W., Suite 700
Washington, D.C. 20005
Telephone: (202) 434-1500
Facsimile: (202) 434-1501

By: 
H. J. Staas
Registration No. 22,010

FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

ATTORNEY DOCKET NO.
1614.1376

APPLICATION NO.

FIRST NAMED INVENTOR

Xin Zhang

FILING DATE

January 2, 2004

GROUP ART UNIT

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB-CLASS	FILING DATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION YES NO
	AG	5-073573	03/1993	Japan			abs
	AH						
	AI						
	AJ						
	AK						
	AL						

OTHER REFERENCES (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

	AM	
	AN	
	AO	

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

ATTACHMENT 1(e)

EXPLANATIONS OF RELEVANCY OF REFERENCES	ATTORNEY DOCKET NO.	APPLICATION NO.
	1614.1376	
	FIRST NAMED INVENTOR Xin Zhang	
	FILING DATE January 2, 2004	GROUP ART UNIT

The reference cited herein fails to teach or suggest a yield percentage managing method which manages a yield percentage of a target processed product with respect to at least one target raw material by use of a computer, by correcting or updating the yield percentage based on a processed amount K which indicates a total number or weight of target items of the target processed product processed from the target raw material.